WHAT IS CLAIMED IS:

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- 1. A manufacturing apparatus comprising:
- a film formation chamber comprising an evaporation source opposing a substrate, means for moving the evaporation source in an X direction, and means for moving the substrate in a Y direction,

wherein a film is deposited on the substrate by repeating moving the evaporation source in the X direction and then moving the substrate in the Y direction at regular intervals.

- 2. The manufacturing apparatus according to claim 1, wherein a plurality of the evaporation source are provided and move in parallel to each other.
 - 3. The manufacturing apparatus according to claim 1, wherein the evaporation source is reciprocated in the X direction.

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- 4. The manufacturing apparatus according to any one of claim 1, wherein the substrate is reciprocated in the Y direction in a film formation chamber.
 - 5. A manufacturing apparatus comprising:
 - a film formation chamber comprising means for moving a substrate in a Y direction;
- a setting chamber connected to the film formation chamber, the setting chamber comprising an evaporation source and means for moving the evaporation source in an X direction from the setting chamber into the film formation chamber,

wherein a film is deposited on the substrate by repeating moving the evaporation source in the X direction and then moving the substrate in the Y direction at regular intervals.

6. The manufacturing apparatus according to claim 5, wherein a container storing an evaporation material is set in the evaporation source without being exposed to an atmosphere outside of the setting chamber.

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- 7. The manufacturing apparatus according to claim 5, wherein the setting chamber has a film thickness meter.
- 8. The manufacturing apparatus according to claim 5, wherein the film formation chamber and the setting chamber are connected to a vacuum discharge treatment chamber for vacuuming the chambers and have means for bringing in a material gas or a cleaning gas.
- 9. The manufacturing apparatus according to claim 5, wherein a plurality of the evaporation source are provided and move in parallel to each other.
- 10. The manufacturing apparatus according to claim 5, wherein the evaporation source is reciprocated in the X direction.
- 11. The manufacturing apparatus according to any one of claim 5, wherein the substrate is reciprocated in the Y direction in a film formation chamber.

12. A manufacturing apparatus comprising:

a film formation chamber comprising a first evaporation source provided to be opposite to a substrate, first means for moving the first evaporation source in an X direction, a second evaporation source provided to be opposite to the substrate, second means for moving the second evaporation source in the X direction, and means for moving the substrate in a Y direction,

wherein a film is deposited by repeatedly moving the substrate in the Y direction at regular intervals while making a movement speed of the first evaporation source in the X direction and a movement speed of the second evaporation source in the X direction different.

- 13. The manufacturing apparatus according to claim 12, wherein film thickness meters of adjacent first and second evaporation sources are disposed alternately so as to sandwich a movement pathway of the substrate.
 - 14. The manufacturing apparatus according to claim 12, wherein the first and second

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evaporation sources are reciprocated in the X direction.

- 15. The manufacturing apparatus according to any one of claim 12, wherein the substrate is reciprocated in the Y direction in a film formation chamber.
 - 16. A manufacturing apparatus comprising:
 - a loading chamber;
 - a delivery chamber connected to the loading chamber; and
 - a plurality of film formation chambers connected to the delivery chambers,

wherein each of the plurality of the film formation chambers comprises a plurality of evaporation sources, means for moving the evaporation source in an X direction, and means for moving a substrate in a Y direction, and

wherein a film is deposited on the substrate by moving or reciprocating the evaporation sources in the X direction while moving the substrate in the Y direction at a constant speed.

17. A method for manufacturing a semiconductor device comprising:

depositing a film over a substrate by repeating moving an evaporation source in an X direction and then moving the substrate in a Y direction at regular intervals.

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